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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	. CONFIRMATION NO.		
10/697,760	10/30/2003	Minhua Lu	YOR920030499US1 (17075)	8778		
23389	7590 06/01/2006		EXAM	EXAMINER		
	COTT MURPHY & PRES N CITY PLAZA	CHOWDHURY, TARIFUR RASHID				
SUITE 300	N CITT I LINZIN	ART UNIT	PAPER NUMBER			
GARDEN CI	TY, NY 11530		2871			
			DATE MAILED: 06/01/2006			

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)				
Office Action Summary		10/697,760	LU ET AL.				
		Examiner	Art Unit				
		Tarifur R. Chowdhury	2871				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.  - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).							
Status							
1) Responsive to communication(s)	filed on <i>13 Mar</i>	rch 2006.					
2a) ☐ This action is <b>FINAL</b> .							
<u> </u>							
• • • • • • • • • • • • • • • • • • • •	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims		,					
·	na in the empli	nation					
4) Claim(s) 1-11 and 18 is/are pending in the application.							
4a) Of the above claim(s) is/are withdrawn from consideration.  5) Claim(s) is/are allowed.							
7) Claim(s) is/are objected to.	S)⊠ Claim(s) <u>1-11,18</u> is/are rejected.						
8) Claim(s) are subject to res		election requirement					
	inction and/or e	siection requirement.					
Application Papers							
9) ☐ The specification is objected to by the Examiner.							
10)⊠.The drawing(s) filed on <u>11 February 2004</u> is/are: a)⊠ accepted or b)⊡ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).							
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.							
Priority under 35 U.S.C. § 119							
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of:							
<ol> <li>Certified copies of the prior</li> </ol>	1. Certified copies of the priority documents have been received.						
2. Certified copies of the priority documents have been received in Application No							
3. Copies of the certified copies	3. Copies of the certified copies of the priority documents have been received in this National Stage						
application from the International Bureau (PCT Rule 17.2(a)).							
* See the attached detailed Office action for a list of the certified copies not received.							
				•			
Attachment(s)  1) Notice of Poferences Cited (PTO 893)  A) Intensions Summan (PTO 413)							
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 4) Interview Summary (PTO-413) Paper No(s)/Mail Date.							
3) Information Disclosure Statement(s) (PTO-1449	•	5) Notice of Informal P		<b>O-152</b> )			
Paper No(s)/Mail Date 6) Uther:							

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#### **DETAILED ACTION**

## Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1, 2, 4, 5 and 18 are rejected under 35 U.S.C. 102(b) as being anticipated by Sugawara et al., Sugawara, USPAT 5,438,421.
- 3. As to claims 1 and 18, Sugawara discloses a liquid crystal display (LCD) device comprising a first substrate (fig. 5, ref. 18) having a grooved surface profile (fig. 5, ref. 16), an alignment film layer of inorganic material formed on the grooved surface and having a grooved surface profile, where the alignment film material (fig. 5, ref. 20) is aligned in response to an ion beam (fig. 5c, "ion beam"; col. 11, line 55) incident to the grooved surface and a second substrate (fig. 13, ref. 41) aligned opposite the first substrate and having liquid crystal (LC) material (fig. 13, ref. 42) deposited in between.

As to the limitation of "resulting in an increased alignment force for constraining deposited LC material to a direction parallel to the grooves" is deemed to be inherent. Where the claimed and prior art products are identical or substantially identical in structure or composition, or are produced by identical or substantially identical processes, a prima facie case of anticipation has been established. In re Best, 562 F.2d 1252, 1255, 195 USPQ 430, 433 (CCPA 1977).

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Further, the limitation such as, "being subject to an ion beam incident to said groove surface in a direction parallel to a groove direction to thereby eliminate 90° meta-stable alignment states at the surface of said alignment film layer" is considered as a product by process limitation. "[E]ven though product-by-process claims are limited by and defined by the process, determination of patentability is based on the product itself. The patentability of a product does not depend on its method of production. If the product in the product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product was made by a different process." In re Thorpe, 777F.2d 695, 698, 227 USPQ 964, 966 (Fed. Cir. 1985) (see also MPEP 2113).

Accordingly, claims 1 and 18 are anticipated.

As per claim 2, Sugawara discloses an LCD as recited above where the material of the underlayer comprises an organic resin material (col. 11, lines 50-51).

As to claim 4, Sugawara discloses an LCD as recited above where the second aligned substrate (fig. 21, ref. 41) opposite the first substrate includes a top alignment layer (fig. 21, ref. 45) having a flat surface profile.

As per claim 5, Sugawara discloses an LCD as recited above where the second aligned substrate (fig. 10, ref. 41) opposite the first substrate includes a top alignment layer (fig. 10, ref. 48) having a grooved surface profile.

# Claim Rejections - 35 USC 5 103

4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

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(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The factual inquiries set forth in Graham v. John Deere Co., 383 U.S. 1, 148USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

- 1. Determining the scope and contents of the prior art.
- 2. Ascertaining the differences between the prior art and the claims at issue.
- 3. Resolving the level of ordinary skill in the pertinent art.
- 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

- 5. Claims 6, 7 and 9-11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sugawara in view of Bryan-Brown et al. (U.S. Patent No. 5,917,570, hereafter "Bryan-Brown").
- 6. As to claims 6-7, Sugawara discloses an LCD as recited above, however, the reference fails to specifically disclose a surface anchoring energy that increases when compared to LC materials deposited between flat substrate surfaces and aligning LC

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materials parallel to the grooves enables decreased potential energy.

Bryan-Brown discloses an LCD device where the LC molecules a surface anchoring energy that increases when compared to LC materials deposited between flat substrate surfaces and aligning LC materials parallel to the grooves enables decreased decreased potential energy (fig. 5a, 5b; col. 5, lines 4-15).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have a surface anchoring energy that increases when compared to LC materials deposited between flat substrate surfaces and aligning LC materials parallel to the grooves enables decreased potential energy since one would be motivated to provide pretilted alignment that is essential in avoiding reverse tilt disclinations which can lead to poor device quality (col. 1, lines 59-62), thus providing enhanced LCD performance.

7. Regarding claims 9-11, Sugawara discloses an LCD as recited above where the grooves are not continuous along a lengthwise direction, and where the grooves terminate in a length direction and restart in a slightly difference location with different height and widths (fig. 1, 2), however, the reference fails to specifically disclose a grooved surface profile of the alignment film being sinusoidal.

Bryan-Brown discloses an LCD device having a grooved surface profile of the alignment film being sinusoidal (col. 1, line 57).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have a grooved surface profile of the alignment film being sinusoidal since one would be motivated to provide pretilted alignment that is essential

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in avoiding reverse tilt disclinations which can lead to poor device quality (col. 1, lines 59-62), thus providing enhanced LCD performance.

- 8. Claim 3 and 8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sugawara in view of Callegari et al., (Callegari), USPAT 6,020,946.
- 9. Sugawara discloses an LCD as recited above, however, the reference fails to specifically disclose an alignment film of inorganic material being a diamond-like carbon or selected from a group comprising amorphous hydrogenated silicon, glass, Sic, 302, A1203, Ce02, SnO2, and ZnTiO2.

Callegari discloses an LCD device having an alignment film of inorganic material being a diamond-like carbon or selected from a group comprising amorphous hydrogenated silicon, glass, Sic, Si02, Al203, Ce02, Sn02, and ZnTi02. (col. 3, lines 1-15).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have an alignment film of inorganic material being a diamond like carbon or selected from a group comprising amorphous hydrogenated silicon, glass, Sic, Si02, A1203, Ce02, Sn02, and ZnTi02 since one would be motivated to provide an optically transparent and amorphous or fine-grained material, which are comparable to polyimide films but require fewer steps and are less costly to manufacture (col. 3, lines 8-1 5). Ultimately, this serves to provide greater design flexibility in LCD devices without sacrificing its optical characteristics (col. 3, lines 16-24).

### Response to Arguments

10. Applicant's arguments filed February 13, 2006 have been fully considered but

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they are not persuasive.

In response to applicant's argument that since in Sugawara the ion beam is incident to the grooved surface in a direction perpendicular to a groove direction, he fails to teach IB treatment for the purpose of creating better LC material alignment and more stability of LC material, it is respectfully pointed out to applicant that as explained above the limitation, "being subject to an ion beam incident to said groove surface in a direction parallel to a groove direction to thereby eliminate 90° meta-stable alignment states at the surface of said alignment film layer" is considered as a product by process limitation and it is noted that a product-by-process limitation is recognized as limited by and defined by the process and determination of patentability is based on the product itself. The patentability of a product does not depend on its method of production. If the product in the product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior art product was made by a different process. In re Thorpe, 227 USPQ 964,966 (Fed. Cir. 1985). See also MPEP 2113.

Further, the limitation such as, "resulting in an increased alignment force for constraining deposited LC material to a direction parallel to the grooves" can also be construed as an intended use limitation, it has been held that a recitation with respect to the manner in which a claimed apparatus is intended to be employed does not differentiate the claimed apparatus from a prior art apparatus satisfying the claimed structural limitations. Ex parte Masham, 2 USPQ2d 1647 (1 987). In this case, even if such a limitation were deemed be structural, Applicant's limitation still does not place

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the claim in condition for allowance. Applicant argues that the ion beam treatment in Sugawara is not for "alignment," but rather for etching. However, it is noted again that the purpose of the etching is to provide a grooved profile on which the alignment layer (20) is situated. Thus, the ion beam incident on the grooved surface ultimately generates an increased alignment force on the alignment of the LC material

### Conclusion

11. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tarifur R. Chowdhury whose telephone number is (571) 272-2287. The examiner can normally be reached on M-Th (6:30-5:00) Friday Off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David C. Nelms can be reached on (571) 272-1787. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

TARIFUR R. CHOWDHURY PRIMARY EXAMINER Z

TRC May 24, 2006